

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

**TC74VCX16843FT****LOW-VOLTAGE 18-BIT D-TYPE LATCH  
WITH 3.6 V TOLERANT INPUTS AND OUTPUTS**

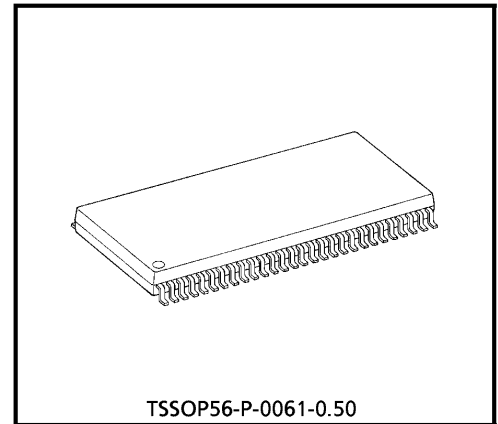
The TC74VCX16843FT is a high performance CMOS 18-bit D-TYPE LATCH. Designed for use in 1.8, 2.5 or 3.3 Volt systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

It is also designed with over voltage tolerant inputs and outputs up to 3.6 V.

The TC74VCX16843FT can be used as two 9-bit latches or one 18-bit latch. The 18 latches are transparent D-type latches. The device has noninverting data (D) inputs and provides true data at its outputs. While the latch-enable (1LE or 2LE) input is high, the Q outputs of the corresponding 9-bit latch follow the D inputs. When LE is taken low, the Q outputs are latched at the levels set up at the D inputs.  $\overline{\text{CLR}}$  and  $\overline{\text{PR}}$  are independent of the LE and are accomplished by setting the appropriate input low.

When the  $\overline{\text{OE}}$  input is high, the outputs are in a high impedance state. This device is designed to be used with 3-state memory address drivers, etc.

All inputs are equipped with protection circuits against static discharge.



TSSOP56-P-0061-0.50

Weight : 0.25 g (Typ.)

**FEATURES**

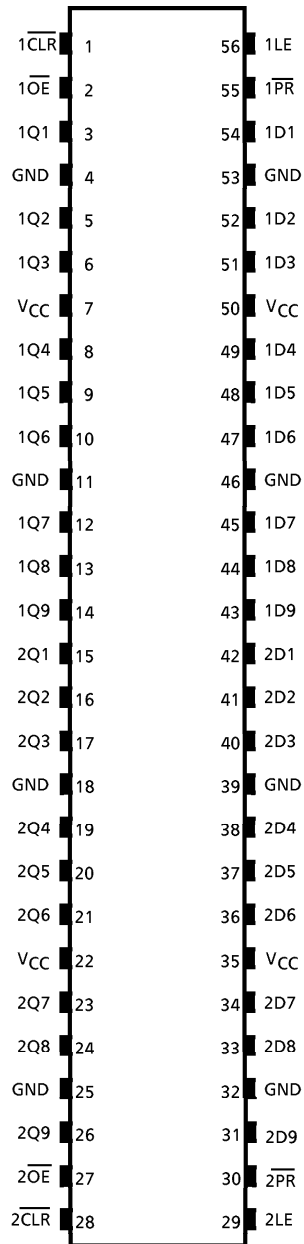
- Low Voltage Operation :  $V_{CC} = 1.8\sim 3.6\text{V}$
- High Speed Operation :  $t_{pd} = 3.0\text{ ns (max) at } V_{CC} = 3.0\sim 3.6\text{ V}$   
                                   :  $t_{pd} = 3.7\text{ ns (max) at } V_{CC} = 2.3\sim 2.7\text{ V}$   
                                   :  $t_{pd} = 7.4\text{ ns (max) at } V_{CC} = 1.8\text{ V}$
- 3.6 V Tolerant inputs and outputs.
- Output Current :  $I_{OH} / I_{OL} = \pm 24\text{ mA (min) at } V_{CC} = 3.0\text{ V}$   
                                   :  $I_{OH} / I_{OL} = \pm 18\text{ mA (min) at } V_{CC} = 2.3\text{ V}$   
                                   :  $I_{OH} / I_{OL} = \pm 6\text{ mA (min) at } V_{CC} = 1.8\text{ V}$
- Latch-up Performance :  $\pm 300\text{ mA}$
- ESD Performance : Human Body Model  $> \pm 2000\text{ V}$   
                                   : Machine Model  $> \pm 200\text{ V}$
- Package : TSSOP  
                                   (Thin Shrink Small Outline Package)
- Power Down Protection is provided on all inputs and outputs.
- Supports live insertion / withdrawal (Note 1)

(Note 1) : To ensure the high-impedance state during power up or power down,  $\overline{\text{OE}}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

980910EBA2

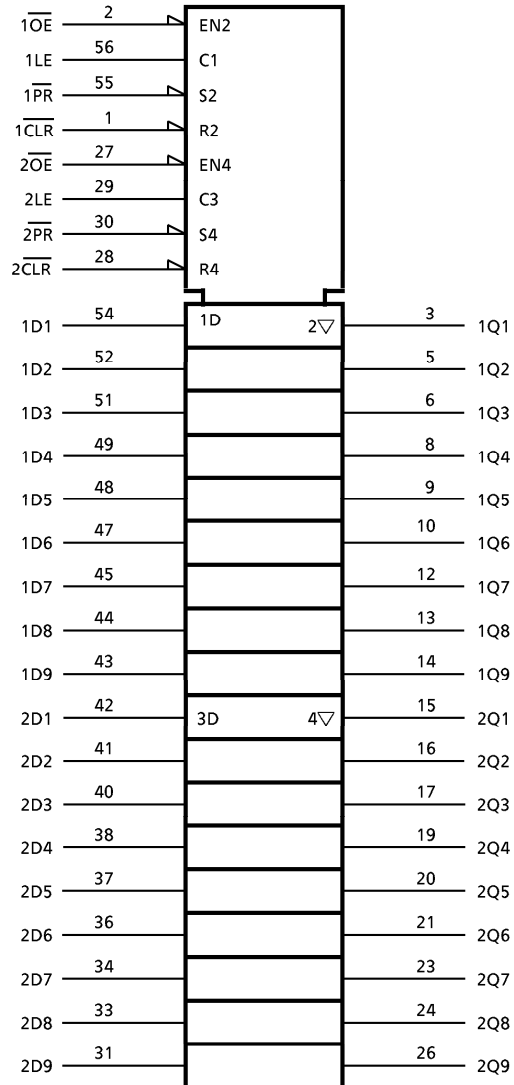
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**PIN ASSIGNMENT**



(TOP VIEW)

**SYMBOL**



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**FUNCTION TABLE** (each 9-bit latch)

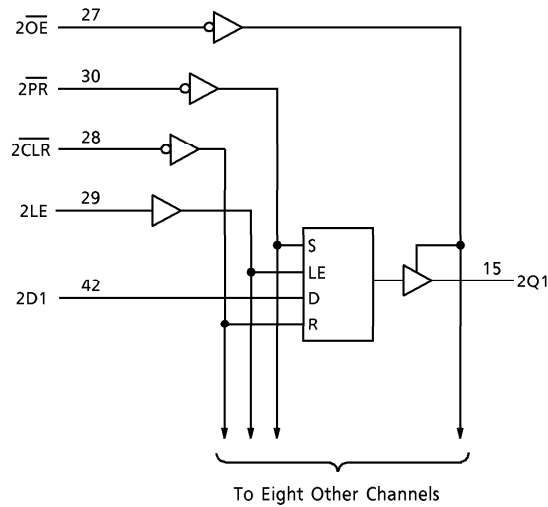
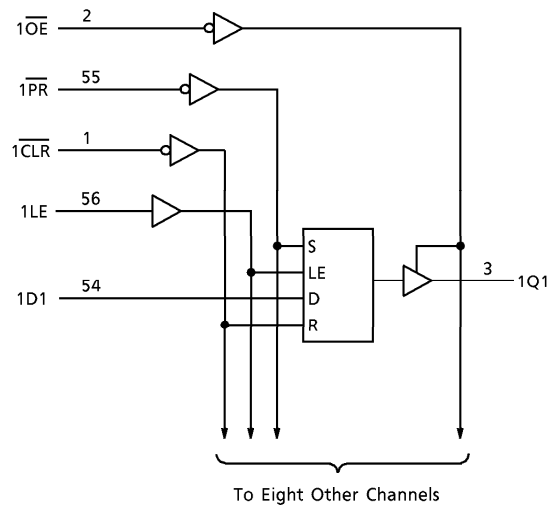
INPUTS					OUTPUT
$\overline{\text{PR}}$	$\overline{\text{CLR}}$	$\overline{\text{OE}}$	LE	D	Q
L	X	L	X	X	H
H	L	L	X	X	L
H	H	L	H	L	L
H	H	L	H	H	H
H	H	L	L	X	Q <sub>n</sub>
X	X	H	X	X	Z

X : Don't care

Z : High impedance

Q<sub>n</sub> : Q outputs are latched at the time when the LE input is taken to a low logic level.

**SYSTEM DIAGRAM**



## MAXIMUM RATINGS

PARAMETER	SYMBOL	RATING	UNIT
Power Supply Voltage	$V_{CC}$	-0.5~4.6	V
DC Input Voltage	$V_{IN}$	-0.5~4.6	V
DC Output Voltage	$V_{OUT}$	-0.5~4.6 (Note 1)	V
		-0.5~ $V_{CC}$ + 0.5 (Note 2)	
Input Diode Current	$I_{IK}$	-50	mA
Output Diode Current	$I_{OK}$	±50 (Note 3)	mA
DC Output Current	$I_{OUT}$	±50	mA
Power Dissipation	$P_D$	400	mW
DC $V_{CC}$ / Ground Current Per Supply Pin	$I_{CC} / I_{GND}$	±100	mA
Storage Temperature	$T_{stg}$	-65~150	°C

(Note 1) : Off-State

(Note 2) : High or Low State.  $I_{OUT}$  absolute maximum rating must be observed.

(Note 3) :  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$

## RECOMMENDED OPERATING RANGE

PARAMETER	SYMBOL	RATING	UNIT
Supply Voltage	$V_{CC}$	1.8~3.6	V
		1.2~3.6 (Note 4)	
Input Voltage	$V_{IN}$	-0.3~3.6	V
Output Voltage	$V_{OUT}$	0~3.6 (Note 5)	V
		0~ $V_{CC}$ (Note 6)	
Output Current	$I_{OH} / I_{OL}$	±24 (Note 7)	mA
		±18 (Note 8)	
		±6 (Note 9)	
Operating Temperature	$T_{opr}$	-40~85	°C
Input Rise And Fall Time	$dt / dv$	0~10 (Note 10)	ns / V

(Note 4) : Data Retention Only

(Note 5) : Off-State

(Note 6) : High or Low State

(Note 7) :  $V_{CC} = 3.0 \sim 3.6$  V

(Note 8) :  $V_{CC} = 2.3 \sim 2.7$  V

(Note 9) :  $V_{CC} = 1.8$  V

(Note 10) :  $V_{IN} = 0.8 \sim 2.0$  V,  $V_{CC} = 3.0$  V

**ELECTRICAL CHARACTERISTICS**

DC characteristics (Ta = -40~85°C, 2.7 V < VCC ≤ 3.6 V)

PARAMETER		SYMBOL	TEST CONDITION		VCC (V)	MIN	MAX	UNIT
Input Voltage	"H" Level	V <sub>IH</sub>			2.7~3.6	2.0	—	V
	"L" Level	V <sub>IL</sub>			2.7~3.6	—	0.8	V
Output Voltage	"H" Level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	2.7~3.6	V <sub>CC</sub> - 0.2	—	V
				I <sub>OH</sub> = -12 mA	2.7	2.2	—	
				I <sub>OH</sub> = -18 mA	3.0	2.4	—	
				I <sub>OH</sub> = -24 mA	3.0	2.2	—	
	"L" Level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.7~3.6	—	0.2	V
				I <sub>OL</sub> = 12 mA	2.7	—	0.4	
				I <sub>OL</sub> = 18 mA	3.0	—	0.4	
				I <sub>OL</sub> = 24 mA	3.0	—	0.55	
Input Leakage Current		I <sub>IN</sub>	V <sub>IN</sub> = 0~3.6 V		2.7~3.6	—	± 5.0	μA
3-State Output Off-State Current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = 0~3.6 V		2.7~3.6	—	± 10.0	μA
Power Off Leakage Current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0~3.6 V		0	—	10.0	μA
Quiescent Supply Current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.7~3.6	—	20.0	μA
			V <sub>CC</sub> ≤ (V <sub>IN</sub> , V <sub>OUT</sub> ) ≤ 3.6 V		2.7~3.6	—	± 20.0	
Increase In I <sub>CC</sub> Per Input		ΔI <sub>CC</sub>	V <sub>IH</sub> = V <sub>CC</sub> - 0.6 V		2.7~3.6	—	750	μA

**ELECTRICAL CHARACTERISTICS**

DC characteristics (Ta = -40~85°C, 2.3 V ≤ VCC ≤ 2.7 V)

PARAMETER		SYMBOL	TEST CONDITION		VCC (V)	MIN	MAX	UNIT
Input Voltage	"H" Level	V <sub>IH</sub>			2.3~2.7	1.6	—	V
	"L" Level	V <sub>IL</sub>			2.3~2.7	—	0.7	V
Output Voltage	"H" Level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	2.3~2.7	V <sub>CC</sub> - 0.2	—	V
				I <sub>OH</sub> = -6 mA	2.3	2.0	—	
				I <sub>OH</sub> = -12 mA	2.3	1.8	—	
				I <sub>OH</sub> = -18 mA	2.3	1.7	—	
	"L" Level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.3~2.7	—	0.2	V
				I <sub>OL</sub> = 12 mA	2.3	—	0.4	
				I <sub>OL</sub> = 18 mA	2.3	—	0.6	
				I <sub>OL</sub> = 18 mA	2.3	—	0.6	
Input Leakage Current		I <sub>IN</sub>	V <sub>IN</sub> = 0~3.6 V		2.3~2.7	—	± 5.0	μA
3-State Output Off-State Current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = 0~3.6 V		2.3~2.7	—	± 10.0	μA
Power Off Leakage Current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0~3.6 V		0	—	10.0	μA
Quiescent Supply Current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.3~2.7	—	20.0	μA
			V <sub>CC</sub> ≤ (V <sub>IN</sub> , V <sub>OUT</sub> ) ≤ 3.6 V		2.3~2.7	—	± 20.0	

## ELECTRICAL CHARACTERISTICS

DC characteristics ( $T_a = -40\sim 85^\circ\text{C}$ ,  $1.8\text{ V} \leq V_{CC} < 2.3\text{ V}$ )

PARAMETER		SYMBOL	TEST CONDITION		$V_{CC}$ (V)	MIN	MAX	UNIT
Input Voltage	"H" Level	$V_{IH}$			1.8~2.3	$0.7 \times V_{CC}$	—	V
	"L" Level	$V_{IL}$			1.8~2.3	—	$0.2 \times V_{CC}$	V
Output Voltage	"H" Level	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100\ \mu\text{A}$	1.8	$V_{CC} - 0.2$	—	V
				$I_{OH} = -6\ \text{mA}$	1.8	1.4	—	
	"L" Level	$V_{OL}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 100\ \mu\text{A}$	1.8	—	0.2	V
				$I_{OL} = 6\ \text{mA}$	1.8	—	0.3	
Input Leakage Current		$I_{IN}$	$V_{IN} = 0\sim 3.6\ \text{V}$		1.8	—	$\pm 5.0$	$\mu\text{A}$
3-State Output Off-State Current		$I_{OZ}$	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0\sim 3.6\ \text{V}$		1.8	—	$\pm 10.0$	$\mu\text{A}$
Power Off Leakage Current		$I_{OFF}$	$V_{IN}, V_{OUT} = 0\sim 3.6\ \text{V}$		0	—	10.0	$\mu\text{A}$
Quiescent Supply Current		$I_{CC}$	$V_{IN} = V_{CC}$ or GND		1.8	—	20.0	$\mu\text{A}$
			$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6\ \text{V}$		1.8	—	$\pm 20.0$	

AC characteristics (Ta = -40~85°C, Input tr = tf = 2.0 ns, CL = 30 pF, RL = 500 Ω)

PARAMETER	SYMBOL	TEST CONDITION	VCC (V)	MIN	MAX	UNIT
Propagation Delay Time (D-Q)	t <sub>pLH</sub> t <sub>pHL</sub>	(Fig.1, 2)	1.8	1.5	7.4	ns
			2.5 ± 0.2	0.8	3.7	
			3.3 ± 0.3	0.6	3.0	
Propagation Delay Time (LE-Q)	t <sub>pLH</sub> t <sub>pHL</sub>	(Fig.1, 2)	1.8	1.5	8.8	ns
			2.5 ± 0.2	0.8	4.4	
			3.3 ± 0.3	0.6	3.5	
Propagation Delay Time (PR-Q)	t <sub>pLH</sub>	(Fig.1, 3)	1.8	1.5	9.8	ns
			2.5 ± 0.2	0.8	5.6	
			3.3 ± 0.3	0.6	4.0	
Propagation Delay Time (CLR-Q)	t <sub>pHL</sub>	(Fig.1, 3)	1.8	1.5	9.2	ns
			2.5 ± 0.2	0.8	4.6	
			3.3 ± 0.3	0.6	3.7	
3-State Output Enable Time	t <sub>pZL</sub> t <sub>pZH</sub>	(Fig.1, 4)	1.8	1.5	9.8	ns
			2.5 ± 0.2	0.8	4.9	
			3.3 ± 0.3	0.6	3.8	
3-State Output Disable Time	t <sub>pLZ</sub> t <sub>pHZ</sub>	(Fig.1, 4)	1.8	1.5	7.6	ns
			2.5 ± 0.2	0.8	4.2	
			3.3 ± 0.3	0.6	3.7	
Minimum Pulse Width (LE, PR, CLR)	t <sub>w</sub> (H) t <sub>w</sub> (L)	(Fig.1, 2, 3)	1.8	4.0	—	ns
			2.5 ± 0.2	1.5	—	
			3.3 ± 0.3	1.5	—	
Minimum Set-up Time	t <sub>s</sub>	(Fig.1, 2)	1.8	2.5	—	ns
			2.5 ± 0.2	1.5	—	
			3.3 ± 0.3	1.5	—	
Minimum Hold Time	t <sub>h</sub>	(Fig.1, 2)	1.8	1.0	—	ns
			2.5 ± 0.2	1.0	—	
			3.3 ± 0.3	1.0	—	
Minimum Removal Time	t <sub>rem</sub>	(Fig.1, 5)	1.8	4.0	—	ns
			2.5 ± 0.2	3.0	—	
			3.3 ± 0.3	2.0	—	
Output to Output Skew	t <sub>osLH</sub> t <sub>osHL</sub>	(Note 11)	1.8	—	0.5	ns
			2.5 ± 0.2	—	0.5	
			3.3 ± 0.3	—	0.5	

For CL = 50 pF, add approximately 300 ps to the AC maximum specification.

(Note 11) : Parameter guaranteed by design.

$$(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$$

Dynamic switching characteristics (Ta = 25°C, Input tr = tf = 2.0 ns, CL = 30 pF)

PARAMETER	SYMBOL	TEST CONDITION	VCC (V)	TYP.	UNIT
Quiet Output Maximum Dynamic VOL	VOLP	VIH = 1.8 V, VIL = 0 V (Note 12)	1.8	0.25	V
		VIH = 2.5 V, VIL = 0 V (Note 12)	2.5	0.6	
		VIH = 3.3 V, VIL = 0 V (Note 12)	3.3	0.8	
Quiet Output Minimum Dynamic VOL	VOLV	VIH = 1.8 V, VIL = 0 V (Note 12)	1.8	-0.25	V
		VIH = 2.5 V, VIL = 0 V (Note 12)	2.5	-0.6	
		VIH = 3.3 V, VIL = 0 V (Note 12)	3.3	-0.8	
Quiet Output Minimum Dynamic VOH	VOHV	VIH = 1.8 V, VIL = 0 V (Note 12)	1.8	1.5	V
		VIH = 2.5 V, VIL = 0 V (Note 12)	2.5	1.9	
		VIH = 3.3 V, VIL = 0 V (Note 12)	3.3	2.2	

(Note 12) : Parameter guaranteed by design.

Capacitive characteristics (Ta = 25°C)

PARAMETER	SYMBOL	TEST CONDITION	VCC (V)	TYP.	UNIT
Input Capacitance	CIN		1.8, 2.5, 3.3	6	pF
Output Capacitance	CO		1.8, 2.5, 3.3	7	pF
Power Dissipation Capacitance	CpD	fIN = 10 MHz (Note 13)	1.8, 2.5, 3.3	20	pF

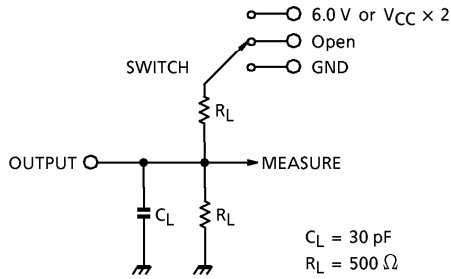
(Note 13) : CpD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

$$I_{CC}(\text{opr.}) = C_{pD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 18 \text{ (per bit)}$$

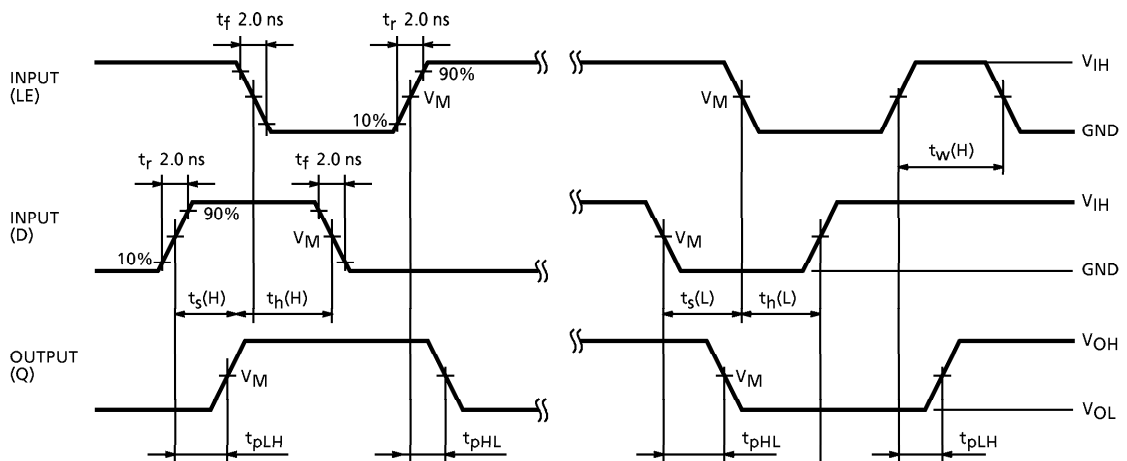


**TEST CIRCUIT**  
Fig.1



PARAMETER	SWITCH
$t_{pLH}, t_{pHL}$	Open
$t_{pLZ}, t_{pZL}$	6.0 V @ $V_{CC} = 3.3 \pm 0.3 \text{ V}$ $V_{CC} \times 2$ @ $V_{CC} = 2.5 \pm 0.2 \text{ V}$ @ $V_{CC} = 1.8 \text{ V}$
$t_{pHZ}, t_{pZH}$	GND

**AC WAVEFORM**  
Fig.2  $t_{pLH}, t_{pHL}, t_w, t_s, t_h$



**Fig.3  $t_{pLH}, t_{pHL}, t_w$**

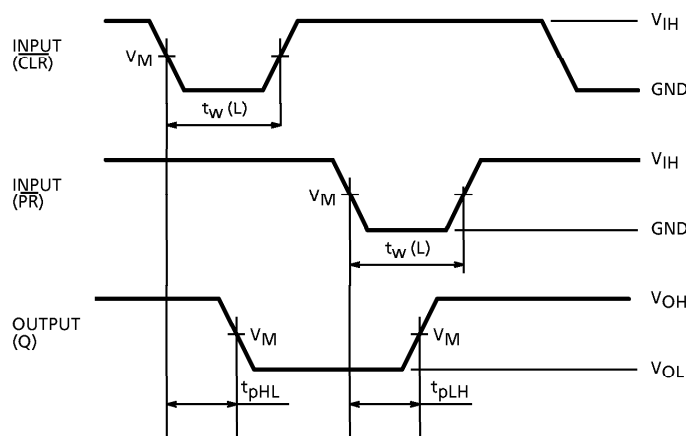
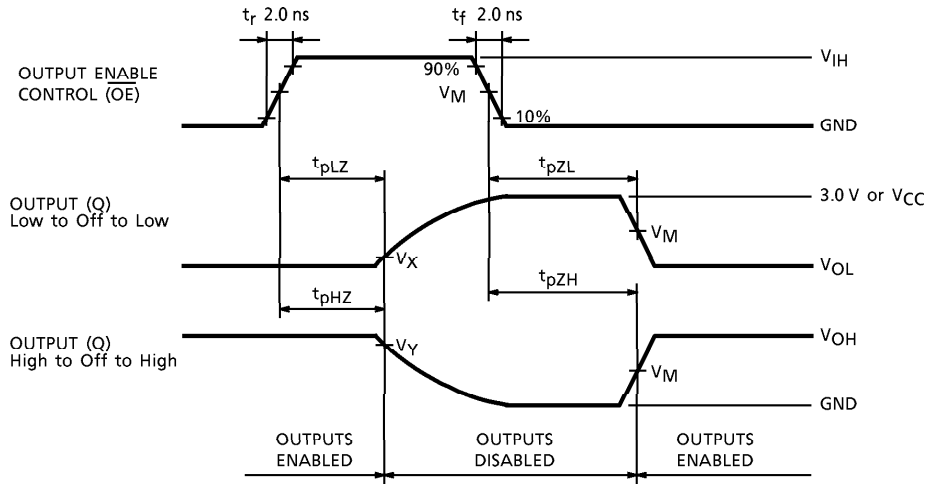
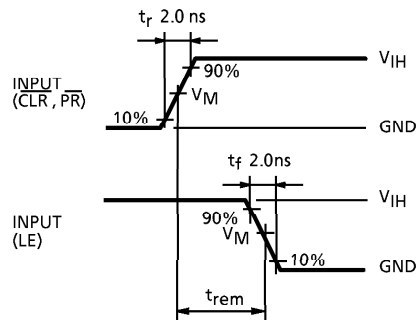


Fig.4  $t_{pLZ}$ ,  $t_{pHZ}$ ,  $t_{pZL}$ ,  $t_{pZH}$



SYMBOL	$V_{CC}$		
	$3.3 \pm 0.3 V$	$2.5 \pm 0.2 V$	$1.8 V$
$V_{IH}$	$2.7 V$	$V_{CC}$	$V_{CC}$
$V_M$	$1.5 V$	$V_{CC} / 2$	$V_{CC} / 2$
$V_X$	$V_{OL} + 0.3 V$	$V_{OL} + 0.15 V$	$V_{OL} + 0.15 V$
$V_Y$	$V_{OH} - 0.3 V$	$V_{OH} - 0.15 V$	$V_{OH} - 0.15 V$

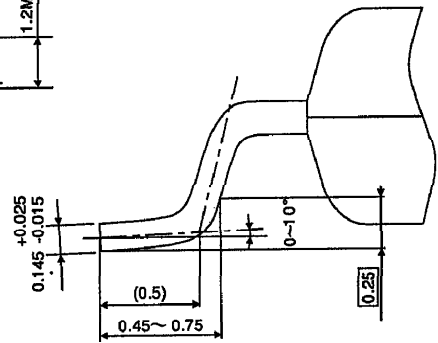
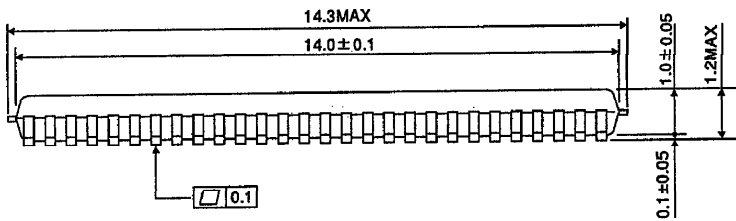
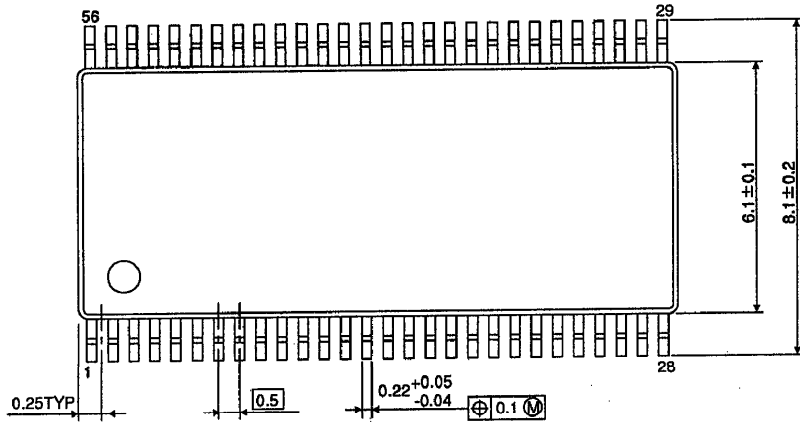
Fig.5  $t_{rem}$



**PACKAGE DIMENSIONS**

TSSOP56-P-0061-0.50

Unit : mm



Weight : 0.25 g (Typ.)